Search Notes		

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/750,006	EBIHARA, MIKA	
	Examiner	Art Unit	_
_	Donghee Kang	2811	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	34,349,37 7,399	3/30/2005	KANG

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
east uspto,uspgpub,epo,jpo,dew,ibmtdb	3/30/2005	KANG
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